SN54ALS133, SN74ALS133 13-INPUT POSITIVE-NAND GATES

SDAS202B - APRIL 1982 - REVISED DECEMBER 1994

 Package Options Include Plastic Small-Outline (D) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

^ldescription

These devices contain a 13-input positive-NAND gate. They perform the following Boolean functions in positive logic:

$$Y = \overline{A \cdot B \cdot C \cdot D \cdot E \cdot F \cdot G \cdot H \cdot I \cdot J \cdot K \cdot L \cdot M}$$

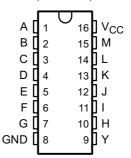
$$Y = \overline{A + \overline{B} + \overline{C} + \overline{D} + \overline{E} + \overline{F} + \overline{G} + \overline{H} + \overline{I} + \overline{J} + \overline{K} + \overline{L} + \overline{M}}$$

The SN54ALS133 is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ALS133 is characterized for operation from 0°C to 70°C.

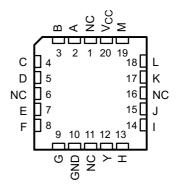
FUNCTION TABLE

INPUTS A – M	OUTPUT Y					
All inputs H	L					
One or more inputs L	Н					

SN54ALS133...J PACKAGE SN74ALS133...D OR N PACKAGE (TOP VIEW)

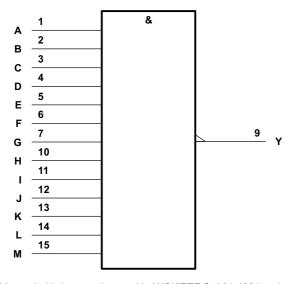


SN54ALS133 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

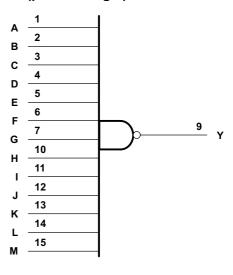
logic symbol†



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for the D, J, and N packages.

logic diagram (positive logic)



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TEXAS

SN54ALS133, SN74ALS133 13-INPUT POSITIVE-NAND GATES

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V _{CC}	7 V
Input voltage, V _I	
Operating free-air temperature range, T _A : SN54ALS133	
SN74ALS133	0°C to 70°C
Storage temperature range	-65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

		SN54ALS133			SN	UNIT			
		MIN	NOM	MAX	MIN	NOM	MAX	UNII	
V _C C	Supply voltage	4.5	5	5.5	4.5	5	5.5	V	
V_{IH}	High-level input voltage	2			2			V	
.,	Low-level input voltage			0.8‡			0.8	V	
V_{IL}				0.7§				V	
ІОН	High-level output current	-0.4				-0.4	mA		
loL	Low-level output current			4			8	mA	
T_{A}	Operating free-air temperature	-55		125	0		70	°C	

[‡] Applies over temperature range -55°C to 70°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST CONDITIONS		SN	SN54ALS133			SN74ALS133			
PARAMETER TEST CONDITIONS		ONDITIONS	MIN	MIN TYP¶ MAX		MIN TYP¶ M		MAX	IAX	
VIK	$V_{CC} = 4.5 V$,	I _I = –18 mA			-1.2			-1.5	V	
V _{OH}	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -0.4 \text{ mA}$	V _{CC} -2	!		V _{CC} -2			V	
	V _{CC} = 4.5 V	$I_{OL} = 4 \text{ mA}$		0.25	0.5		0.25	0.4	V	
V _{OL}		$I_{OL} = 8 \text{ mA}$					0.35	0.5	V	
Ι _Ι	$V_{CC} = 5.5 V$,	V _I = 7 V			0.1			0.1	mA	
lін	$V_{CC} = 5.5 V$,	V _I = 2.7 V			20			20	μΑ	
I _{IL}	$V_{CC} = 5.5 V$,	V _I = 0.4 V			-0.1			-0.1	mA	
IO [#]	$V_{CC} = 5.5 V$,	$V_0 = 2.25 V$	-20		-112	-30		-112	mA	
ІССН	$V_{CC} = 5.5 V,$	V _I = 0		0.24	0.34		0.24	0.34	mA	
^I CCL	$V_{CC} = 5.5 V$,	V _I = 4.5 V		0.56	0.8		0.56	0.08	mA	

 $[\]P$ All typical values are at V_{CC} = 5 V, T_A = 25°C.



[§] Applies over temperature range 70°C to 125°C

[#]The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

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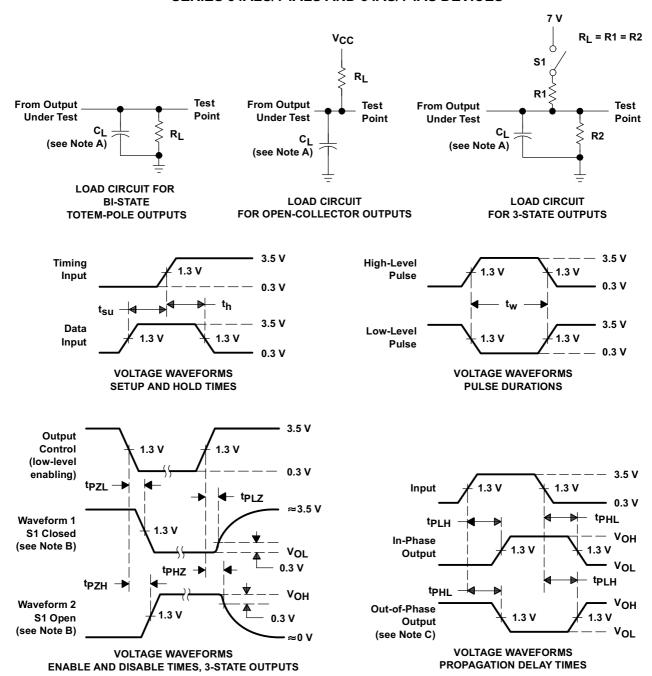
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switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _C C _L R _L T _A	UNIT			
			SN54ALS133		SN74ALS133		
			MIN	MAX	MIN	MAX	
^t PLH	Δny	V	1	16	3	11	nc
^t PHL	Any	ſ	1	47	5	25	ns

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES: A. C_I includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- D. All input pulses have the following characteristics: PRR \leq 1 MHz, $t_{\Gamma} = t_{f} = 2$ ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



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